Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/801,376	LEE ET AL.	
Examiner	Art Unit	
 Ajay Vasudeva	3617	

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Class	Subclass	Date	Examiner
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B29C 065/34 B29C 065/36	11/12/2005	A
Text Search Class 156, 219, 264 (see notes)		
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